



A Generalized HSPICE* Macro-Model for Pseudo-Spin-Valve GMR Memory Bits

by Bodhisattva Das

William C. Black, Jr.

Department of Electrical and Computer Engineering, Iowa State University

(Work sponsored in part by Honeywell SSEC; and DARPA)



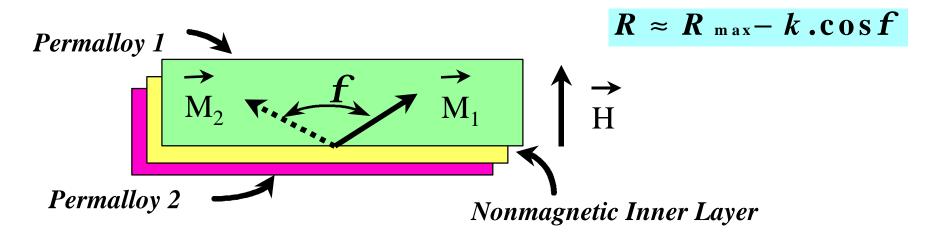
*HSPICE is an authorized trademark of Avant! Corporation

IEEE ISCAS 98 Monterey, CA

- Introduction to Giant Magneto Resistance (GMR) Devices
- GMR Characteristics and Applications
- Pseudo-Spin-Valve Characteristics
 - Typical
 - Generalized
- HSPICE Macro-Model
 - Schematic
 - Attributes
 - Simulation
- Current and Future Work
- Summary and Conclusion

________Introduction to GMR Devices

- Two ferromagnetic layers separated by non-magnetic *spacer* layer
- **Spin-Valve**: one layer *pinned* by anti-ferromagnetic layer
- **Pseudo-Spin-Valve**: both the layers are free to rotate (not pinned)



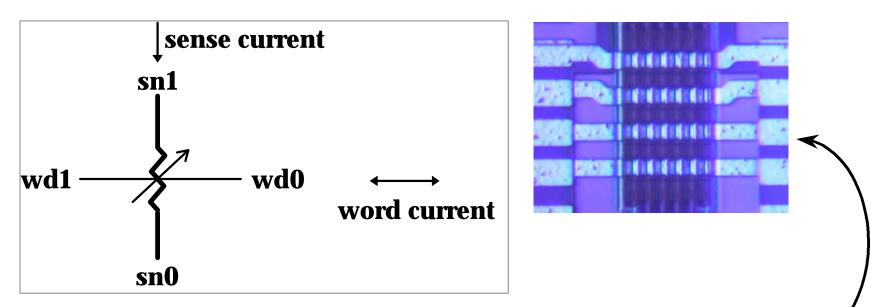
- **Resistance is function of** *difference* **between magnetizations**
- Variations of 6%+ have been demonstrated for practical bits

Typical Characteristics andApplications of GMR

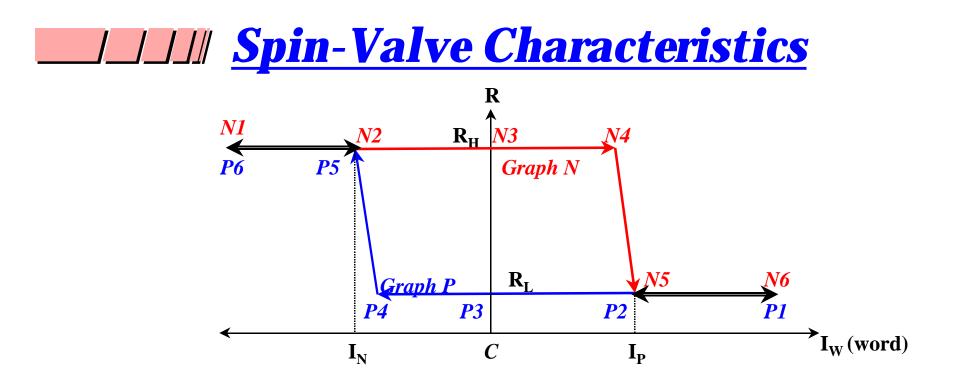
- Characteristics:
 - Stable magnetic states (*non-volatile*)
 - Resistant to ionizing radiation
 - Significant signal improvement relative to older singlelayered Anisotropic Magneto Resistance (AMR) material

• Applications:

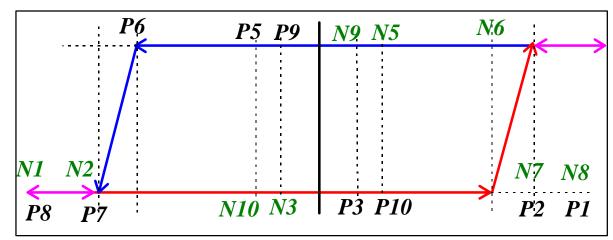
- Non-volatile memory (MRAM)
- Magnetic sensors
- Disk read-heads
- Isolation devices



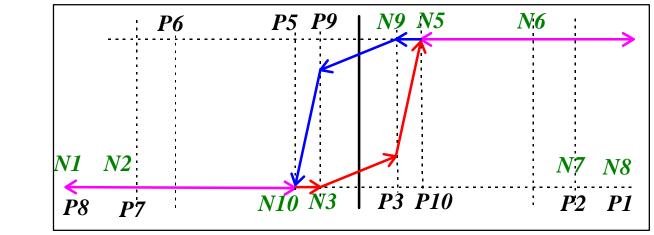
- Read with sense current (may stack bits)
- Write design options:
 - word current alone (small memories)
 - coincident sense and word current (large memories)



- Hysteretic in nature
- Combination of graphs P and N. I_W>I_P: Graph P; I_W<I_N: Graph N
- Two distinct states : Graph P : St. 1 ; Graph N : St. 0 (or vice versa)
- $I_W > I_P$: write to St. 1; $I_W < I_N$: write to St. 0; $I_N < I_W < I_P$: read
- I_N and I_P are weak functions of sense current



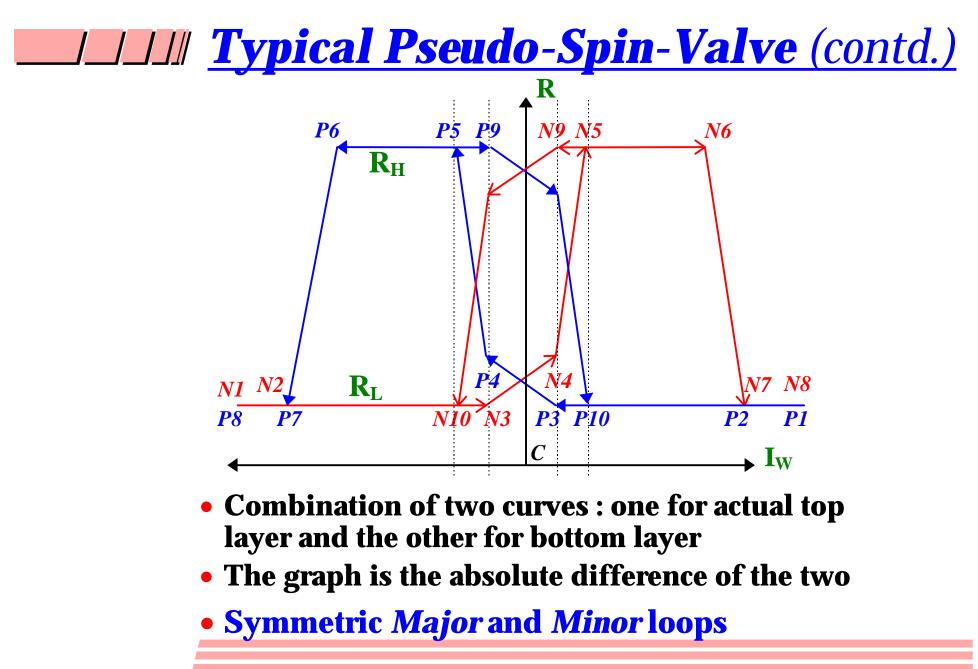
Bottom (*harder***) layer** magnetization curve: higher coercive force



Top (softer) layer magnetization curve: lower coercive force

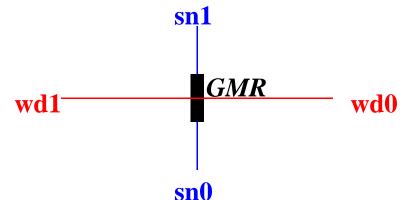
June 3, 1998

B. Das, W. C. Black ECpE - ISU

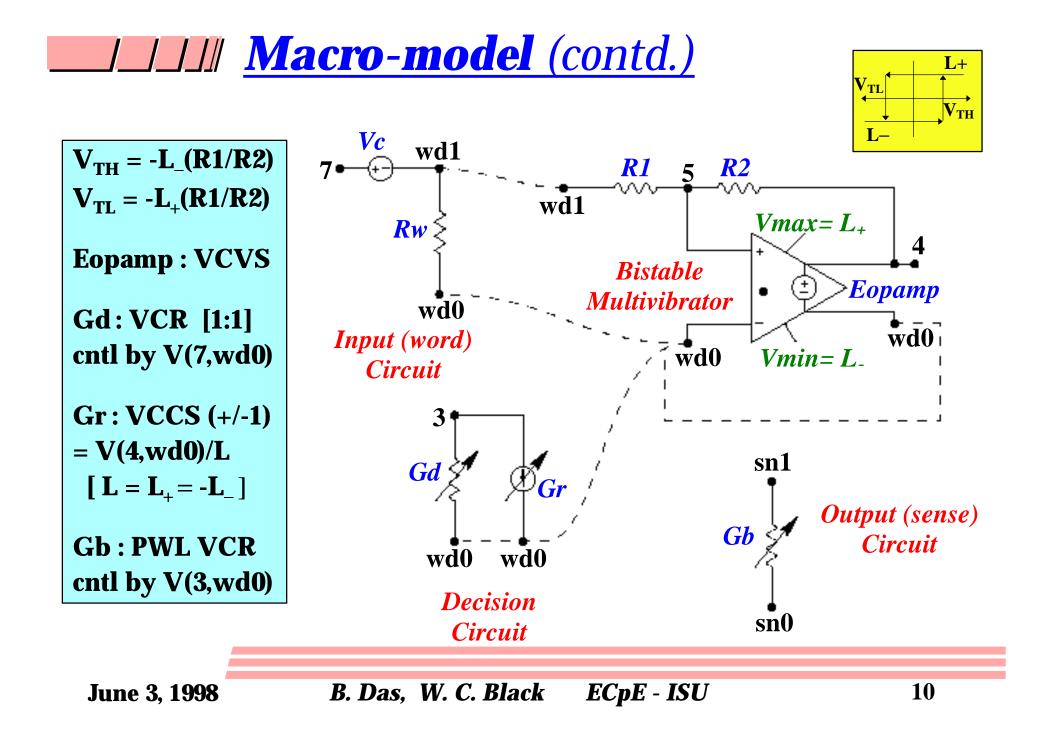


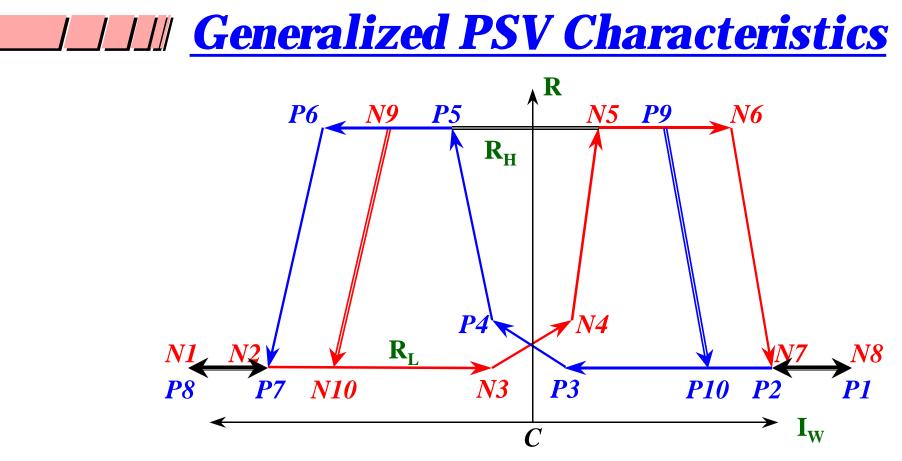
______ <u>Macro-model</u>

- Four terminal sub-circuit :
 - Two word line terminals, two sense line terminals



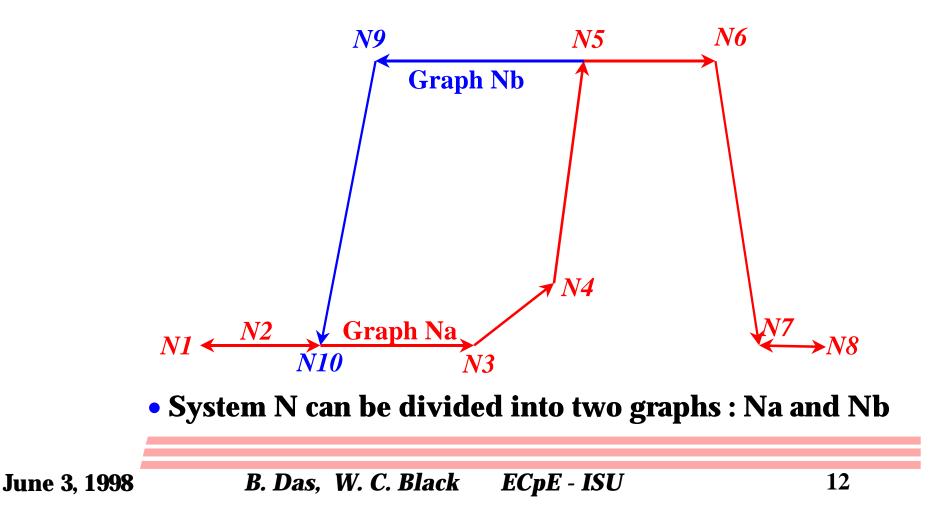
- Four simple parts :
 - Input (word) circuit
 - Bistable multivibrator or Schmitt Trigger
 - Decision circuit
 - Output (sense) circuit

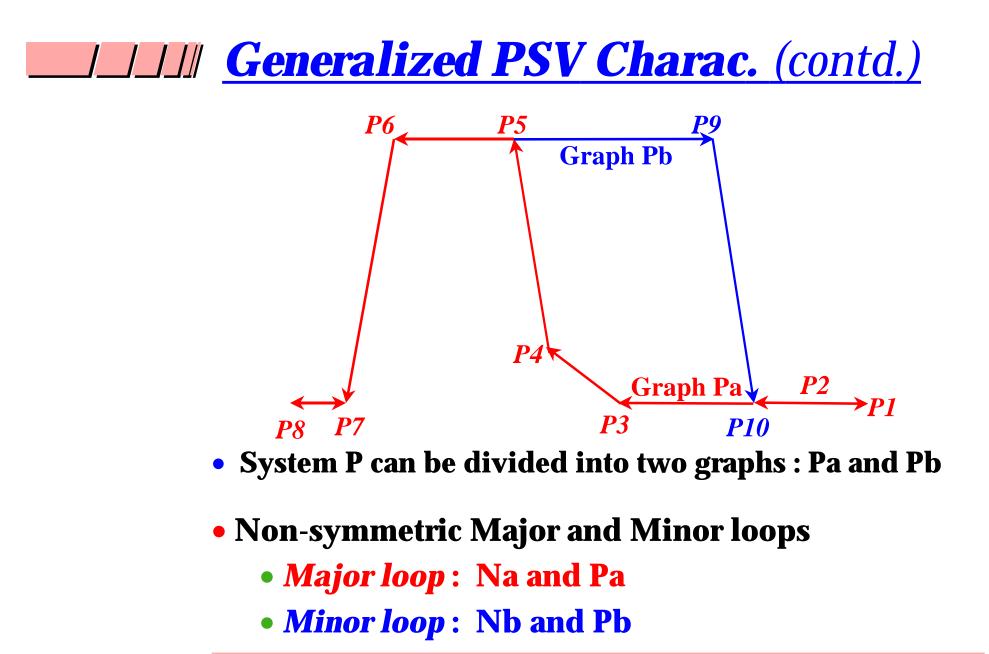




- Hysteretic in nature: combination of systems P and N $I_W > I_{P2}$: System P; $I_W < I_{N2}$: System N
- Each *system* can be divided into two graphs
- Four distinct states can be utilized: two bit memory

- **_______ Generalized PSV Charac.** (contd.)
- As two-state memory : $I_W > I_{P2}$, $I_W < I_{N2}$: write ; $I_{N2} < I_W < I_{P2}$: read
- I_{N2} and I_{P2} (*write thresholds*) are weak functions of sense current





_____ Attributes of the Model

• <u>Versatility</u>

- Usable with any kind of PSV GMR elements
- Generalized and simple : can be modified easily to represent other kinds of hysteretic characteristics

• <u>Flexibility</u>

- All variables parameterized : .PARAM statements
- No component needing power supply : non-volatile

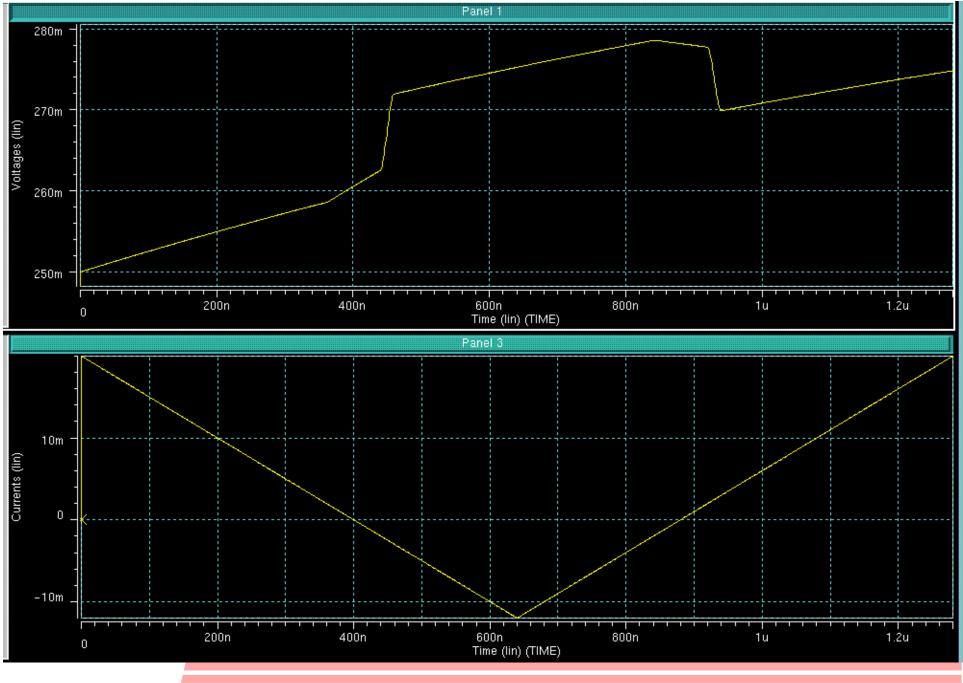
• **Portability**

- subcircuit (.inc) can be included in any HSPICE netlist: great help for GMR memory testing
- No semiconductor device : no variation with different device models

- Sub-circuit simulated with HSPICE : *did converge*!
- Simulations give proper results
- ΔR for the GMR bit : 5% with $R_L = 100\Omega$, $R_H = 105\Omega$
- DC analysis done for a wide range of word currents
- Transient analysis shows proper major and minor loop characteristics
- Simulation of non-volatile latch structures with this GMR model
- Simulation of novel Pseudo-Spin-Valve GMR memory structures with this model (the structure can detect all four states but destructive read)

_______ Current and Future Work

- Already done:
 - Thermal behavior (transient and dc) incorporated
 - Asteroid curve incorporated: write thresholds depend on sense current value
- In the pipeline:
 - Noise analysis (*transient ?*), esp. near the write thresholds
 - A universal GMR model usable for both memory and magnetic sensors (including read heads)



June 3, 1998

B. Das, W. C. Black ECpE - ISU

• <u>First HSPICE circuit model for Pseudo-Spin-</u> <u>Valve GMR element</u>

- Successfully modeled the resistance vs. word current characteristic of a Pseudo-Spin-Valve GMR bit
- The model is simple, flexible and versatile
- Simulations show proper results
- The model is very general in nature, can be applied to other hysteretic characteristics
- Extended to include thermal effects and sense-currentdependency of write thresholds

_____ Questions ?

June 3, 1998

B. Das, W. C. Black ECpE - ISU

19